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, "Front Matter: Volume 11038," Proc. SPIE 11038, X-Ray Free-Electron Lasers: Advances in Source Development and Instrumentation V, 1103801 (5 August 2019); doi: 10.1117/12.2535700

SPIE.

Event: SPIE Optics + Optoelectronics, 2019, Prague, Czech Republic

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X-Ray Free-Electron Lasers: Advances in Source Development and Instrumentation V

Thomas Tschentscher
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Editors

3–4 April 2019
Prague, Czech Republic

Sponsored and Published by
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Volume 11038

Proceedings of SPIE 0277-786X, V. 11038

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X-Ray Free-Electron Lasers: Advances in Source Development and Instrumentation V, edited by Thomas Tschentscher, Luc Patthey, Kai Tiedtke, Marco Zangrando, Proc. of SPIE Vol. 11038, 1103801 © 2019 SPIE
CCC code: 0277-786X/19/\$18 · doi: 10.1117/12.2535700

Proc. of SPIE Vol. 11038 1103801-1

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Author(s), "Title of Paper," in *X-Ray Free-Electron Lasers: Advances in Source Development and Instrumentation V*, edited by Thomas Tschentscher, Luc Patthey, Kai Tiedtke, Marco Zangrando, Proceedings of SPIE Vol. 11038 (SPIE, Bellingham, WA, 2019) Seven-digit Article CID Number.

ISSN: 0277-786X
ISSN: 1996-756X (electronic)

ISBN: 9781510627420
ISBN: 9781510627437 (electronic)

Published by
SPIE
P.O. Box 10, Bellingham, Washington 98227-0010 USA
Telephone +1 360 676 3290 (Pacific Time) · Fax +1 360 647 1445
[SPIE.org](https://spie.org)
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